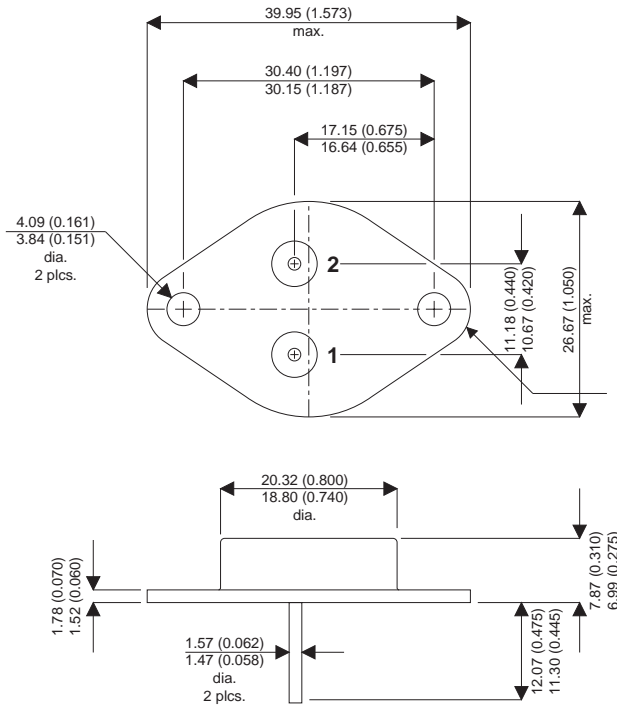


**MECHANICAL DATA**

Dimensions in mm (inches)



**N-CHANNEL  
POWER MOSFET**

$V_{DSS}$                 **60V**  
 $I_{D(cont)}$             **44A**  
 $R_{DS(on)}$             **0.028Ω**

**FEATURES**

- HERMETICALLY SEALED TO-3 METAL PACKAGE
- SIMPLE DRIVE REQUIREMENTS
- SCREENING OPTIONS AVAILABLE

**TO-3 Metal Package**

Pin 1 – Gate            Pin 2 – Source            Case – Drain

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$  unless otherwise stated)

$V_{GS}$	Gate – Source Voltage	$\pm 20V$
$I_D$	Continuous Drain Current ( $V_{GS} = 0, T_{case} = 25^{\circ}C$ )	44A
$I_D$	Continuous Drain Current ( $V_{GS} = 0, T_{case} = 100^{\circ}C$ )	27A
$I_{DM}$	Pulsed Drain Current <sup>1</sup>	176A
$P_D$	Power Dissipation @ $T_{case} = 25^{\circ}C$	125W
	Linear Derating Factor	1.0W/ $^{\circ}C$
$E_{AS}$	Single Pulse Avalanche Energy <sup>2</sup>	340mJ
dv/dt	Peak Diode Recovery <sup>3</sup>	4.5V/ns
$T_J, T_{stg}$	Operating and Storage Temperature Range	-55 to 150 $^{\circ}C$
$T_L$	Lead Temperature 1.6mm (0.63") from case for 10 sec.	300 $^{\circ}C$

**Notes**

- 1) Pulse Test: Pulse Width  $\leq 300\mu s$ ,  $\delta \leq 2\%$
- 2) @  $V_{DD} = 25V, L \geq 200\mu H, R_G = 25\Omega$ , Peak  $I_L = 44A$ , Starting  $T_J = 25^{\circ}C$
- 3) @  $I_{SD} \leq 44A, di/dt \leq 250A/\mu s, V_{DD} \leq BV_{DSS}, T_J \leq 150^{\circ}C$ , Suggested  $R_G = 9.1\Omega$

**ELECTRICAL CHARACTERISTICS** ( $T_{\text{case}} = 25^{\circ}\text{C}$  unless otherwise stated)

Parameter	Test Conditions	Min.	Typ.	Max.	Unit
<b>STATIC ELECTRICAL RATINGS</b>					
$BV_{\text{DSS}}$ Drain – Source Breakdown Voltage	$V_{\text{GS}} = 0$ $I_{\text{D}} = 1\text{mA}$	60			V
$\Delta BV_{\text{DSS}} / \Delta T_{\text{J}}$ Temperature Coefficient of Breakdown Voltage	Reference to $25^{\circ}\text{C}$ $I_{\text{D}} = 1\text{mA}$		0.68		$\text{V}/^{\circ}\text{C}$
$R_{\text{DS(on)}}$ Static Drain – Source On-State Resistance <sup>1</sup>	$V_{\text{GS}} = 10\text{V}$ $I_{\text{D}} = 27\text{A}$			0.028	$\Omega$
	$V_{\text{GS}} = 10\text{V}$ $I_{\text{D}} = 44\text{A}$			0.032	
$V_{\text{GS(th)}}$ Gate Threshold Voltage	$V_{\text{DS}} = V_{\text{GS}}$ $I_{\text{D}} = 250\text{mA}$	2		4	V
$g_{\text{fs}}$ Forward Transconductance <sup>1</sup>	$V_{\text{DS}} \geq 15\text{V}$ $I_{\text{DS}} = 27\text{A}$	17			S ( $\bar{\cup}$ )
$I_{\text{DSS}}$ Zero Gate Voltage Drain Current	$V_{\text{GS}} = 0$ $V_{\text{DS}} = 0.8BV_{\text{DSS}}$ $T_{\text{J}} = 125^{\circ}\text{C}$			25	$\mu\text{A}$
				250	
$I_{\text{GSS}}$ Forward Gate – Source Leakage	$V_{\text{GS}} = 20\text{V}$			100	nA
$I_{\text{GSS}}$ Reverse Gate – Source Leakage	$V_{\text{GS}} = -20\text{V}$			-100	
<b>DYNAMIC CHARACTERISTICS</b>					
$C_{\text{iss}}$ Input Capacitance	$V_{\text{GS}} = 0$		2400		pF
$C_{\text{oss}}$ Output Capacitance	$V_{\text{DS}} = 25\text{V}$		1100		
$C_{\text{riss}}$ Reverse Transfer Capacitance	$f = 1\text{MHz}$		230		
$Q_{\text{g}}$ Total Gate Charge	$V_{\text{GS}} = 10\text{V}$	39		88	nC
$Q_{\text{gs}}$ Gate – Source Charge	$I_{\text{D}} = 44\text{A}$	6.7		15	
$Q_{\text{gd}}$ Gate – Drain (“Miller”) Charge	$V_{\text{DS}} = 0.5BV_{\text{DSS}}$	18		52	
$t_{\text{d(on)}}$ Turn–On Delay Time	$V_{\text{DD}} = 30\text{V}$ $I_{\text{D}} = 44\text{A}$ $R_{\text{G}} = 9.1\Omega$			23	ns
$t_{\text{r}}$ Rise Time				130	
$t_{\text{d(off)}}$ Turn–Off Delay Time				81	
$t_{\text{f}}$ Fall Time				79	
<b>SOURCE – DRAIN DIODE CHARACTERISTICS</b>					
$I_{\text{S}}$ Continuous Source Current				44	A
$I_{\text{SM}}$ Pulse Source Current <sup>2</sup>				176	
$V_{\text{SD}}$ Diode Forward Voltage <sup>1</sup>	$I_{\text{S}} = 44\text{A}$ $T_{\text{J}} = 25^{\circ}\text{C}$ $V_{\text{GS}} = 0$			2.5	V
$t_{\text{rr}}$ Reverse Recovery Time	$I_{\text{F}} = 44\text{A}$ $T_{\text{J}} = 25^{\circ}\text{C}$			220	ns
$Q_{\text{rr}}$ Reverse Recovery Charge <sup>1</sup>	$d_{\text{i}} / d_{\text{t}} \leq 100\text{A}/\mu\text{s}$ $V_{\text{DD}} \leq 50\text{V}$			1.6	$\mu\text{C}$
$t_{\text{on}}$ Forward Turn–On Time		Negligible			
<b>PACKAGE CHARACTERISTICS</b>					
$L_{\text{D}}$ Internal Drain Inductance (measured from 6mm down drain lead to centre of die)			5.0		nH
$L_{\text{S}}$ Internal Source Inductance (from 6mm down source lead to source bond pad)			13		
<b>THERMAL CHARACTERISTICS</b>					
$R_{\theta\text{JC}}$ Thermal Resistance Junction – Case				1.0	$^{\circ}\text{C}/\text{W}$
$R_{\theta\text{CS}}$ Thermal Resistance Case – Sink			0.12		
$R_{\theta\text{JA}}$ Thermal Resistance Junction – Ambient				30	

**Notes**

- 1) Pulse Test: Pulse Width  $\leq 300\text{ms}$ ,  $\delta \leq 2\%$
- 2) Repetitive Rating – Pulse width limited by maximum junction temperature.



LittleDiode supplies new, hard to find or obsolete electronic components and semiconductors all over the world.

With over two million different components listed you are sure to find the part you need.

Feel free to visit us today at our online store:

[LittleDiode.com](http://LittleDiode.com)

Looking forward to providing you with the best possible service.